

INFORMATION DISCLOSURE CITATION (USE SEVERAL SHEETS IF NECESSARY)						ATTY. DOCKET NO. Serie 5935		SERIAL NO. Not yet assigned	
								APPLICANT(S) Sophie WASTIAUX, et al.	
FILING DATE Herewith							GROUP Unknown		
U.S. PATENT DOCUMENTS									
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date		
JW	A1	US 3 868 847	3/04/1975	Gunkel	—	—			
JW	A2	US 4 924 707 Equivalent of EP 0 305 637	5/15/1990	Kliesch	—	—			
JW	A3	US 5 677 490	10/14/1997	Gunther et al.	—	—			
JW	A4	US 5 804 730	9/08/1998	Pfannenstiel et al.	—	—			
FOREIGN PATENT DOCUMENTS									
		Document Number	Date	Country	Class	Subclass	Translation Yes No		
JW	B1	EP 0 166 666	1/02/1986	Europe	—	—			
JW	B2	EP 0 305 637 Equivalent: US 4 924 707	3/08/1989	Europe	—	—			
	B3	EP 0 816 840	1/07/1998	Europe	—	—			
	B4	GB 2 195 022	3/23/1988	United Kingdom	—	—			
	B5	GB 2 198 532	6/15/1988	United Kingdom	—	—			
	B6	GB 2 219 907	12/20/1989	United Kingdom	—	—			
	B7	WO 02 31487	4/18/2002	PCT	—	—			
JW	B8	WO 02 44709	6/06/2002	PCT	—	—			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)									
JW	C1	International Search Report for PCT/FR03/01798							
JW	C2	Lilly J. et al.: "In-line inspection using time-of-flight diffraction", Welding & Metal Fabrication, IPC Ltd., Haywards Heath, GB, vol. 59, no. 8, October 1, 1991, pages 457-458, 460							
Examiner <i>Treguer Jean-Luc</i>					Date Considered <i>03/02/06</i>				
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